

Docket No.: 265980US0PCT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION: Hiroyuki YANO, et al.

SERIAL NO.: 10/524,757

GAU: 1641

FILED: February 11, 2005

EXAMINER: VENCI, David J.

FOR: METHOD OF DETECTING ALLERGEN PROTEIN

LETTER SUBMITTING REPLACEMENT DRAWING SHEET(S)

COMMISSIONER FOR PATENTS
Alexandria, VA 22313

SIR:

Responsive to the below indicated communication, the following drawing sheets are submitted herewith:

☒ 4 Replacement Drawing Sheets

☐ _____ New Drawing Sheets

☒ Official Action dated July 10, 2007

☐ Notice of Allowance/Issue Fee dated _____

☐ Other dated _____

The changes and/or modifications made include the following:

On 8/9/2007 and 9/27/2007 Mr. David J. Venci was contacted (by telephone) regarding the rejection of the drawings (submitted with the application on February 11, 2005) in the Official Action dated 7/10/2007. The quality of the figures scanned by the U.S. Patent Office and viewed in PAIR was poor. It is now possible to submit the attached Replacement Drawing Sheets for Figs. 2A, 2B, 3, 4 & 5 on a higher resolution scanner, which produces a higher quality photograph. Having discussed this with Ex. Venci, and having agreed upon the re-submission of the drawings, we are hereby attaching the aforementioned photographs for Figs. 2A, 2B, 3, 4 & 5 for review. No new matter has been introduced.

Respectfully Submitted,

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